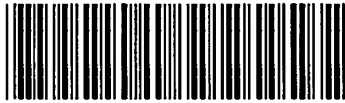


Search Notes

Application/Control No.

10/567,740

Examiner

Tri V. Nguyen

Applicant(s)/Patent under
Reexamination

ASAKA ET AL.

Art Unit

1751

SEARCHED

Class	Subclass	Date	Examiner
252	500	4/1/2007	NVT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see attached)	4/1/2007	NVT
STN (see attached0	4/1/2007	NVT